

MOSFET - N-Channel, POWERTRENCH®

30 V, 15 A, 7.0 m Ω

FDS8817NZ, FDS8817NZ-G

General Description

This N-Channel MOSFET is produced using **onsemi**'s advanced POWERTRENCH process that has been especially tailored to minimize the on-state resistance.

This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

Features

- Max $r_{DS(on)} = 7 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 15 \text{ A}$
- Max $r_{DS(on)} = 10 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 12.6 \text{ A}$
- HBM ESD Protection Level of 3.8 kV Typical*
- High Performance Trench Technology for Extremely Low rDS(on
- High Power and Current Handling Capability
- These Devices are Pb-Free and are RoHS Compliant

Specifications

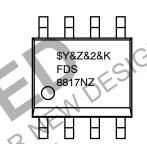
MOSFET MAXIMUM RATINGS (TA = 25°C unless otherwise noted)

| Symbol | Parar | Ratings | Unit | |
|-------------------|---|----------------------|------|----|
| V _{DS} | Drain to Source Voltage | 30 | V | |
| V_{GS} | Gate to Source Voltage | ±20 | V | |
| I _D | Drain Current | Continuous (Note 1a) | 15 | Α |
| | | Pulsed | 60 | |
| E _{AS} | Single Pulse Avalanch | ne Energy (Note 2) | 181 | mJ |
| P _D | Power Dissipation | (Note 1a) | 2.5 | W |
| | 115 | (Note 1b) | 1.0 | |
| T_J , T_{STG} | Operating and Storag Temperature Range | -55 to +150 | °C | |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

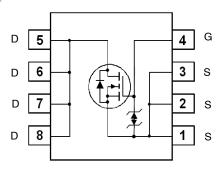


MARKING DIAGRAM



\$Y = onsemi Logo &Z = Assembly Plant Code &2 = Numeric Date Code &K = Lot Code FDS8817NZ = Specific Device Code

PIN ASSIGNMENT



ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

^{*}The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

THERMAL CHARACTERISTICS

| Symbol | Parameter | Ratings | Unit |
|-----------------|---|---------|------|
| $R_{	heta JC}$ | Thermal Resistance, Junction to Case (Note 1) | 25 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 50 | |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1b) | 125 | |

^{1.} R_{0,JA} is the sum of the junction–to–case and case–to–ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0,IC} is guaranteed by design while R_{0,IA} is determined by the user's board design.



a. 50°C/W when mounted on a 1 in² pad of 2 oz copper



b. 125°C/W when mounted on a minimum pad

THIS DEVICE PLEASE NITATIVE FOR INFORMATION REPRESENTATIVE FOR INFORMATION 2. Starting T_J = 25°C; L = 3 mH, I_{AS} = 11 A, V_{DD} = 30 V, V_{GS} = 10 V.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Unit |
|--|---|--|--------|------|------|-------|
| OFF CHARA | CTERISTICS | • | | | | - |
| BV _{DSS} | Drain to Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V$ | 30 | | | V |
| $\Delta BV_{DSS} / \Delta T_{J}$ | Breakdown Voltage Temperature Coefficient | I_D = 250 μ A, referenced to 25°C | | 20 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 24 V, V _{GS} = 0 V | | | 1 | μΑ |
| I _{GSS} | Gate to Source Leakage Current | V _{GS} = ±20 V, V _{DS} = 0 V | | | ±10 | μΑ |
| ON CHARAC | CTERISTICS (Note 3) | | | | | |
| V _{GS(th)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250 \mu A$ | 1 | 1.8 | 3 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | I_D = 250 μ A, referenced to 25°C | | -6 | | mV/°C |
| r _{DS(on)} | Static Drain to Source On Resistance | V _{GS} = 10 V, I _D = 15 A | | 5.4 | 7 | mΩ |
| | | V _{GS} = 4.5 V, I _D = 12.6 A | | 7.0 | 10 | |
| | | V _{GS} = 10 V, I _D = 15 A, T _J = 125°C | | 7.5 | 2/11 | |
| 9FS | Forward Transconductance | V _{DS} = 5 V, I _D = 15 A | | 54 |) | S |
| DYNAMIC C | HARACTERISTICS | | | 71 | | |
| C _{iss} | Input Capacitance | V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz | MF | 1805 | 2400 | pF |
| C _{oss} | Output Capacitance | 01 | in | 335 | 445 | pF |
| C _{rss} | Reverse Transfer Capacitance | | GIL | 200 | 300 | pF |
| Rg | Gate Resistance | f = 1 MHz | | 1.4 | | Ω |
| SWITCHING | CHARACTERISTICS | I PULL | 5/1/11 | | | |
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = 15 \text{ V}, I_D = 15 \text{ A}, V_{GS} = 10 \text{ V},$ | | 11 | 22 | ns |
| t _r | Rise Time | $R_{GEN} = 6 \Omega$ | | 13 | 26 | ns |
| t _{d(off)} | Turn-Off Delay Time | RENTACTOR IN | | 25 | 40 | ns |
| t _f | Fall Time | CHILL | | 7 | 14 | ns |
| Qg | Total Gate Charge | $V_{GS} = 0 \text{ V to } 10 \text{ V}, V_{DD} = 15 \text{ V}, I_D = 15 \text{ A}$ | | 32 | 45 | nC |
| | 15,5 | $V_{GS} = 0 \text{ V to 5 V}, V_{DD} = 15 \text{ V}, I_D = 15 \text{ A}$ | | 17 | 24 | nC |
| Q _{gs} | Gate to Source Charge | V _{DD} = 15 V, I _D = 15 A | | 6 | | nC |
| Q _{gd} | Gate to Drain "Miller" Charge | ~ | | 7 | | nC |
| DRAIN-SOU | IRCE DIODE CHARACTERISTICS | | | | | |
| V _{SD} | Source to Drain Diode Forward Voltage | V _{GS} = 0 V, I _S = 2.1 A (Note 3) | | 8.0 | 1.2 | V |
| t _{rr} | Reverse Recovery Time | I _F = 15 A, di/dt = 100 A/μs | | 24 | 36 | ns |
| Q _{rr} | Reverse Recovery Charge | | | 15 | 23 | nC |
| | unatria resufermente la la disetta di la the Fl | | | | | · |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

^{3.} Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

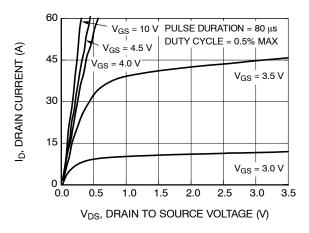


Figure 1. On Region Characteristics

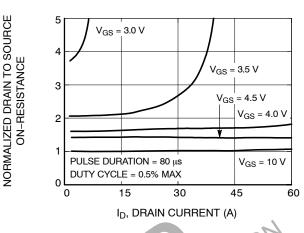


Figure 2. Normalized On-Resistance vs.

Drain Current and Gate Voltage

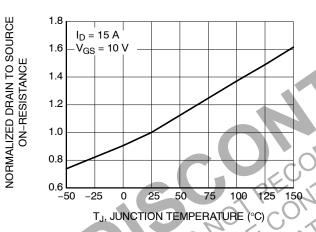


Figure 3. Normalized On Resistance vs. Junction Temperature

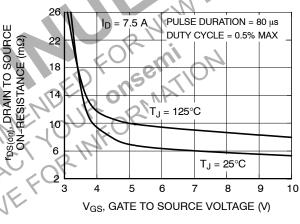


Figure 4. On-Resistance vs. Gate to Source Voltage

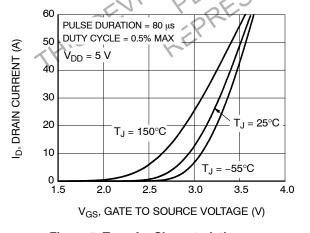


Figure 5. Transfer Characteristics

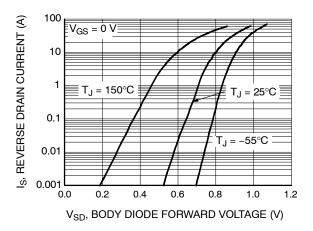


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

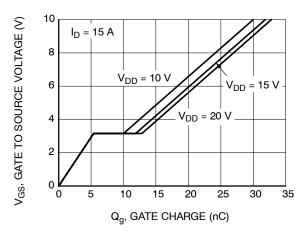


Figure 7. Gate Charge Characteristics

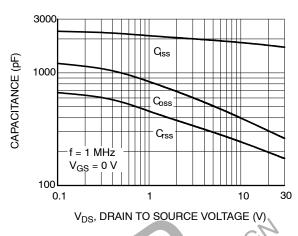


Figure 8. Capacitance vs. Drain to Source Voltage

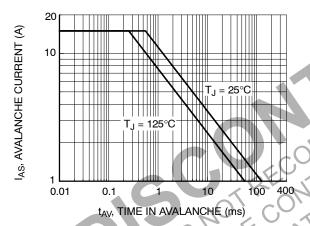


Figure 9. Unclamped Inductive Switching Capability

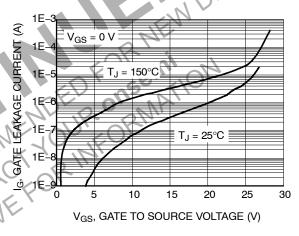


Figure 10. Gate Leakage Current vs. Gate to Source Voltage

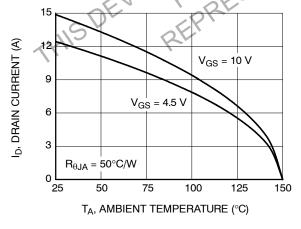


Figure 11. Maximum Continuous Drain Current vs. Ambient Temperature

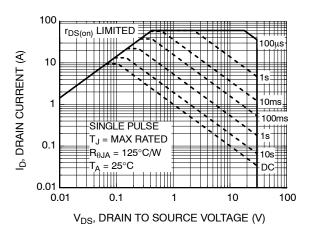


Figure 12. Forward Bias Safe Operating Area

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

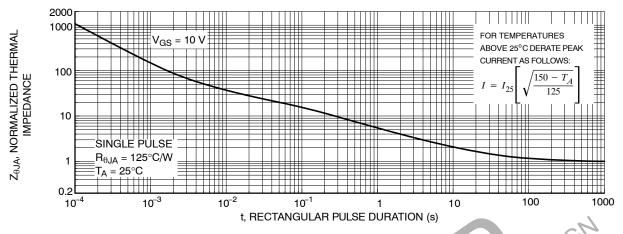


Figure 13. Single Pulse Maximum Power Dissipation

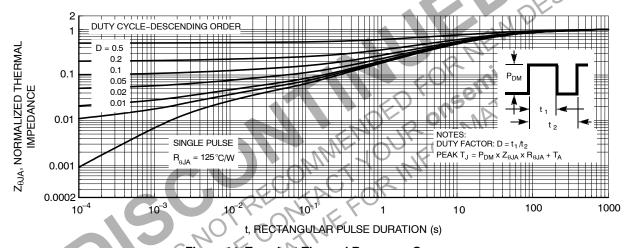


Figure 14. Transient Thermal Response Curve

ORDERING INFORMATION

| Device | Device Marking | Package Type | Shipping [†] |
|-------------|----------------|-----------------|-----------------------|
| FDS8817NZ | FDS8817NZ | SOIC8 (Pb-Free) | 2500 / Tape & Reel |
| FDS8817NZ-G | FDS8817NZ | SOIC8 (Pb-Free) | 2500 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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CASE 751EB **ISSUE A DATE 24 AUG 2017** ·4.90±0.10 → -0.65(0.635)В 6.00±0.20 5.60 3.90±0.10 PIN ONE **INDICATOR** 1.27 1.27 0.25(M) LAND PATTERN RECOMMENDATION В SEE DETAIL A 0.175±0.075 0.22±0.03 С 1.75 MAX 0.10 0.42±0.09 OPTION A - BEVEL EDGE $(0.43) \times 45^{\circ}$ R0.10 GAGE PLANE OPTION B - NO BEVEL EDGE R0.10-0.25 NOTES: A) THIS PACKAGE CONFORMS TO JEDEC MS-012, VARIATION AA. B) ALL DIMENSIONS ARE IN MILLIMETERS. **SEATING PLANE** C) DIMENSIONS DO NOT INCLUDE MOLD 0.65±0.25 FLASH OR BURRS. D) LANDPATTERN STANDARD: SOIC127P600X175-8M (1.04)**DETAIL** À SCALE: 2:1 Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. **DOCUMENT NUMBER:** 98AON13735G

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